Ghost-imaging-enhanced non-invasive spectral characterization of stochastic x-ray free-electron-laser pulses

Kai Li,^{1,2,*} Joakim Laksman,³ Tommaso Mazza,³ Gilles Doumy,²

Dimitris Koulentianos,² Alessandra Picchiotti,⁴ Svitovar Serkez,³ Nina

Rohringer,^{5,6} Markus Ilchen,⁷ Michael Meyer,³ and Linda Young^{1,2,8,†}

¹Department of Physics, The University of Chicago, Chicago, IL 60637 USA ²Chemical Sciences and Engineering Division,

Argonne National Laboratory, Lemont, IL 60439 USA

³European XFEL, Holzkoppel 4, 22869 Schenefeld Germany

⁴The Hamburg Centre for Ultrafast Imaging, Hamburg University, Luruper Chaussee 149, 22761, Hamburg, Germany ⁵Center for Free-Electron Laser Science CFEL, Deutsches Elektronen-Synchrotron DESY, Notkestraße 85, 22607 Hamburg, Germany

⁶Department of Physics, Universität Hamburg, 20355 Hamburg, Germany

⁷Deutsches Elektronen-Synchrotron DESY,

Notkestraße 85, 22607 Hamburg, Germany

⁸James Franck Institute, The University of Chicago, Chicago, IL 60637 USA (Dated: April 11, 2024)

Abstract

High-intensity ultrashort X-ray free-electron laser (XFEL) pulses are revolutionizing the study of fundamental nonlinear x-ray matter interactions and coupled electronic and nuclear dynamics. To fully exploit the potential of this powerful tool for advanced x-ray spectroscopies, a noninvasive spectral characterization of incident stochastic XFEL pulses with high resolution is a key requirement. Here we present a new methodology that combines high-acceptance angle-resolved photoelectron time-of-flight spectroscopy and ghost imaging to dramatically enhance the quality of spectral characterization of x-ray free-electron laser pulses. Implementation of this non-invasive high-resolution x-ray diagnostic can greatly benefit the ultrafast x-ray spectroscopy community by functioning as a transparent beamsplitter for applications such as transient absorption spectroscopy as well as covariance-based x-ray nonlinear spectroscopies where the shot-to-shot fluctuations inherent to a SASE XFEL pulse are a powerful asset.

^{*} kail@anl.gov

[†] young@anl.gov

I. INTRODUCTION

X-ray free-electron lasers, with brilliance ten orders of magnitude higher than synchrotrons, continuous tunability over the soft and hard x-ray regimes and sub-femtosecond pulse duration [1], have emerged as a powerful tool both to explore fundamental nonlinear x-ray interactions in isolated atomic and molecular systems |2-7|, and, to follow photoinduced electronic and nuclear dynamics on their intrinsic femtosecond timescales via pump/probe techniques [8, 9]. For the latter objective, core-level x-ray transient absorption (XTAS) with ultrafast x-ray pulses has become a workhorse - it projects core electronic states onto unoccupied valence/Rydberg states, thereby capturing the evolution of valence electronic motion following an excitation pulse. However, realization of XTAS is challenging at XFELs where the x-ray pulses with bandwidth $\Delta E/E \sim 1\%$, typically produced by self-amplified spontaneous emission (SASE), have spiky temporal and spectral profiles that vary stochastically on a shot-by-shot basis [10-14]. The traditional approach for XTAS with XFELs is to monochromatize the SASE beam [15, 16] and scan the monochromatic beam $(\Delta E/E \sim 0.01\%)$ across the desired spectral range. This makes inefficient use of the full XFEL beam, imposes limits on time resolution via the uncertainty principle, and, by reducing the pulse intensities, hampers realization of nonlinear x-ray spectroscopies. An alternative approach is to monitor incident and transmitted intensity to obtain an absorption spectrum, $I_T(\omega)/I_0(\omega)$, across the entire SASE bandwidth. With this approach one may realize novel experimental techniques employing correlation analysis that take advantage of the intrinsic stochastic nature of XFELs pulses [17–20]. By using pulses with uncorrelated fluctuations one can leverage the noise such that each repetition of the experiment, i.e. each XFEL shot, represents a new measurement under different conditions. As an example, spectral ghost imaging has been applied to obtain an absorption spectrum with energy resolution better than the averaged SASE bandwidth [21, 22]. In general, the characterization of the incident pulses is essential to this class of novel covariance spectroscopies as previously demonstrated in UV regime [23].

Several diagnostic tools have demonstrated well-resolved spectral measurements on a single-shot basis without compromising the quality of the x-ray beam. A commonality is the use of optical elements to split the incident x-ray beam into reference and sample beams. Beamsplitters for hard x-rays use crystal Bragg diffraction [24, 25] while diffraction

gratings are used for soft x-rays[26, 27]. An alternative is to use photoionization of a dilute target gas and measure the kinetic energy of ejected photoelectrons to retrieve the incident photon spectrum via the photoelectric effect [28–30]. Indeed, the use of an array of 16 electron time-of-flight spectrometers (eTOFs) radially distributed about the propagating x-ray beam (colloquially named the "cookie-box") has enabled the measurement of the position, polarization, and central energy of an x-ray photon beam as demonstrated at the PETRA-P04 beamline [28]. At XFELs, while it is straightforward to measure the central photon energy with the cookie-box [29] as has been demonstrated for two-color x-ray pulses [31] and to obtain simultaneous polarization diagnostics [32, 33], it is more challenging to obtain single-shot spectra with an energy resolution comparable to a grating spectrometer.

Here we use a ghost-imaging algorithm to improve the energy resolution of the raw cookie-box measurements. Thousands of SASE spectra were measured simultaneously by a cookie-box and a grating spectrometer and ghost imaging was applied to compute the response matrix of the cookie-box. The response matrix was then used to reconstruct the x-ray spectrum with energy resolution improved from ~ 1 eV to 0.5 eV at a central energy of 910 eV for a resolution of $\Delta E/E \sim 1/2000$ under the present conditions. This response matrix derived from ghost imaging also provides predictive power for the spectral profile of yet-to-be-measured XFEL pulses.

II. RESULTS

A. Spectral ghost imaging

Ghost imaging is an experimental technique which uses statistical fluctuations of an incident beam to extract information about an object using a beam replica that has not physically interacted with the object [34]. It can be used in the spatial[35, 36], temporal[18] and spectral[21, 22] domains. Traditional ghost imaging requires a beam splitter to separate the incident beam into two replicas, the object beam and the reference beam. The object beam interacts with the sample and a low-resolution detector is used to measure the signal whose intensity is proportional to the interaction and the incident beam. The reference beam is directly measured by a high-resolution detector to extract knowledge of the incident beam. The incident light source varies shot-by-shot and numerous measurements are carried out to

calculate the correlation function between the two signals from the object and the reference beams. The correlation function of the measurements is analyzed to extract information of the sample. The advantage of ghost imaging is that the object beam does not necessarily need to be strong – thus protecting the samples from radiation damage. In addition, due to the fluctuations of the light source and correlation analysis, ghost imaging is robust to noise and background signals.

Ghost imaging essentially maps the high-resolution signal onto the low-resolution one, making it an ideal tool to calibrate devices with high resolution. The correlation function generated by ghost imaging contains information on the response of a device to the different incident signals. This extracted information can be further used to correct defects or discrimination present in a device. The ghost imaging calibration method reconstructs a high quality signal that achieves resolution beyond the low-resolution instrumental limit. The stochastic nature of a SASE XFEL makes it well-suited for ghost imaging in the temporal and spectral domains. Here, ghost imaging is used to calibrate the eToFs of the cookie-box and obtain a response matrix, which is then applied to reconstruct a more accurate incident x-ray spectrum. One challenge for applying the ghost imaging method in the x-ray regime is the requirement of a beamsplitter. Although x-ray beamsplitters are available as mentioned above, the non-invasive gas-target measurement is suitable to replace the function of the beamsplitter.

B. Experimental procedure

The energy spectrum of the incident x-ray beam was characterized non-invasively by photoionization of dilute neon gas at the center of an array of 16-eToFs, i.e. the cookie-box[29] as shown in Fig. 1. The arrival times of Ne 1s photoelectrons were measured by the eToFs located in the plane perpendicular to the beam propagation direction (see Supplementary Note 1). SIMION simulations were carried out to establish a traditional calibration between the electron time-of-flight and kinetic energy, E_k , given the drift tube length and retardation voltages. The incident photon energy was derived by adding the Ne 1s binding energy, 870 eV, to the measured E_k . The spectrum obtained by cookie-box for several random shots using this traditional method is shown in Fig. 1 as the object measurement. Under the present experimental conditions, the energy resolution achievable by the cookie-box was around 1



FIG. 1. Schematic of the experimental setup. SASE XFEL pulses first interact with dilute neon gas in the cookie-box chamber where the kinetic energies of 1s photoelectrons are measured by the array of eToFs. The transmitted x-ray pulse is then focused on the VLS grating by a spherical mirror and dispersed on a YAG:Ce crystal. The induced fluorescence is recorded by a charge-coupled device (CCD) as a 2D image from which the single-shot "reference" spectrum is extracted.

eV, which is not comparable to the high-resolution grating spectrometer measurement where 0.2 eV FWHM ($\Delta E/E$) can be readily achieved.

After passing through cookie-box, the same FEL beam was characterized by a spectrometer based on a VLS grating and a Ce:YAG screen as shown in Fig. 1 as the reference measurement. The cookie-box contains very dilute gas which does not attenuate or otherwise alter the x-ray beam. Thus, ideally the same spectrum would be obtained from the electron (cookie-box) and photon (grating spectrometer) measurements. However, the measurement of a single random shot shown in Fig. 3a reveals differences. The grating spectrometer resolution is much higher than the resolution of the cookie-box, thus creating a large deviation between the two spectra. The use of ghost imaging to retrieve a response matrix which is then used to improve the performance of the cookie-box measurements is demonstrated in the following.

C. Principle of reconstruction

Theoretically the photoelectron signal c (after normalization to the gas density) is proportional to the incident photon spectrum s as measured by the spectrometer

$$c = As \tag{1}$$

where A relates the cookie-box signals to the incident photon spectrum, is an $(m \times n)$ matrix with the cookie-box ToF points m = 137 and the spectrograph pixels n = 1900 in the region of interest between 895 and 920 eV. This equation resembles the basic equation in ghost imaging and is usually used to obtain sample information by solving for A. However, in order to predict the incident spectrum based on cookie-box measurements, we formally write equation (1) as

$$s = Rc \tag{2}$$

where the response matrix R is the formal inverse of matrix A. R maps the low-resolution cookie-box measurements to high-resolution grating spectrometer measurements. In other words, R is a calibration matrix contains information of the characteristics of eToFs. After retrieving the response matrix R, according to equation (2), it can be used to generate high-resolution spectrum with the intrinsic defects and broadening of cookie-box removed.

D. Ghost imaging reconstructed spectrum

To solve equation (2), we take advantage of the N independent measurements obtained. Each shot gives a realization of s_i and c_j in equation $s_i = \sum_{j=1}^m R_{ij}c_j$ with m unknown variables R_{ij} . Combining all measurements gives N independent linear equations which can be solved to uniquely determine the unknown variables if N > m. Instead of directly solving these equations, the response matrix elements are determined by least square regression, i.e. by minimizing the quantity $|s - Rc|^2$. Single-photon Ne 1s ionization exhibits a dipole angular distribution pattern due to the linear (horizontal) polarization of the x-rays and the spherical 1s electron orbital. To increase the signals, we combined six eToFs near the polarization direction which have strong 1s peaks, to form the cookie-box measurement vector c with dimension $m = 6 \times 137 = 822$.

The calculated cookie-box response matrix using all shots (N = 15337) is shown in Fig. 2. Compared with the traditional calibration function, which just maps ToFs onto kinetic



FIG. 2. The cookie-box response matrix computed with six eToFs and all the shots N = 15337.

energy, here we retrieved a matrix whose values represent the sensitivity of the cookie-box to photons of different energy. As expected, there are six different calibration lines connecting the eToFs to spectrograph pixels. The linewidth represents the instrumental broadening. One eToF does not work well and gives relatively small signals. We tried different regression optimizers and got essentially the same response matrix, demonstrating the robustness of our method. As discussed below, the response matrix can be used to obtain a better spectrum. Note that one can quickly obtain the traditional calibration lines of eToFs, by fitting the lines within a nonconverged response matrix obtained by using only 1500 shots.

It is reasonable to assume the response matrix of the cookie-box does not change for a given photon energy, gas target, photoelectron energy range and cookie-box configuration (fixed retardation, bias voltage...); thus R can be used to predict the spectra of new shots. Higher resolution electron spectra s_r can be reconstructed by multiplying the response matrix R by the cookie-box measurement c according to equation (2). As illustrated in Fig. 3, the peak profile and intensities of the cookie-box data (a) are changed after multiplying the matrix with the cookie-box measurement (b).

The photon spectrum in Fig. 3 **b** was convolved with a Gaussian function with $\sigma=0.2$ eV to compare with the ghost-imaging-reconstructed spectrum. The σ was derived by considering the number of data points in the cookie-box versus the spectrometer measurement. There are $1900/137 \approx 14$ spectrograph pixels between two eToF points; multiplying by the 0.013 eV/pixel dispersion of the spectrometer gives 0.2 eV which we take to be σ . One function of reconstruction is to remove instrumental broadening. Thus one observes the higher



FIG. 3. Single-shot electron-derived and photon spectra before (**a**) and after (**b**) ghost-imaging reconstruction. **a** Raw electron-based spectrum from a single eToF (blue) and grating-based photon spectrum (red). **b** Ghost-imaging-reconstructed electron-based spectrum (blue) and the grating-based spectrum after convolution with a Gaussian ($e^{-x^2/(2\sigma^2)}$ with $\sigma = 0.2$ eV).

resolution of the reconstructed spectrum, which matches well with the convolved grating spectrometer measurement. This also indicates that in our case the resolution of reconstructed spectrum is limited by the number of data points within the Ne 1s photoelectron peak of cookie-box signal.

To quantify the performance of the reconstruction, we calculated the standard deviation of the difference signal between the electron-derived and the photon spectra s_i

$$\Delta \sigma_{e-p} = \sqrt{\frac{\sum_{i=1}^{n} |(c_i - s_i) - (\bar{c} - \bar{s})|^2}{n}}$$
(3)

where \bar{s} and \bar{c} are the mean value of spectrometer and cookie-box measurement, respectively, n is the number of spectrometer pixels. Depending on the situation, the value of c_i is either interpolated cookie-box data of one eToF or the ghost imaging reconstructed spectrum. As shown in Fig. 4 the deviation $\Delta \sigma_{e-p}$ of reconstructed spectrum drops to half of the original value, which indicates the improvement after reconstruction. In addition, the smaller fluctuation of the deviations means that the reconstructed spectrum is stable and more reliable than the raw electron-derived spectrum. The significantly better matching of spectrum after ghost-imaging is further confirmed by a good correlation between reconstructed and



FIG. 4. Improvement in spectral resolution from the ghost imaging algorithm. $\Delta \sigma_{e-p}$ is the standard deviation of the difference between cookie-box and spectrometer measurements. Original (blue) and after the ghost-imaging reconstruction (red). Data from six eToFs and all the shots were used to converge the regression and determine the response matrix R. The results of 1000 shots are shown here.

photon spectrum i.e. averaging 0.72 Pearson correlation coefficient across the spectrum (see Supplementary Note 2).

E. Predictive power and performance analysis

One of the most interesting aspects of the ghost imaging method is its predictive power for future shots. This requires numerous "learning" shots to obtain a converged response matrix. Data from six eToFs were used and the response matrix learned from different number of shots is then used to predict the spectra for 100 new shots that were not used in the regression. As shown in Fig. 5, when fewer shots are used, the deviation of the learning shots is small because the regression is under-determined. Meanwhile, the deviation for the new shots is large, indicating a poor predictive power of an unconverged response matrix. As the information from more shots are included in the regression process, the deviation of learning shots rises, whereas the deviation for the new shots decreases indicating the gain of predictive power. The regression converges when the deviation of learning and prediction meet around 8000 shots (roughly 10 times the number of unknown variables i.e. cookie-box vector elements). It is important to note that as more shots are used the error bar for the



FIG. 5. Number of learning shots required for robust predictive capability. The standard deviation for learning and prediction shots as a function of number of shots used in the regression. The inserted plot at fewer number of learning shots (1433) shows a marked jump in standard deviation from learning to prediction shots, while the standard deviation remains relatively constant when more learning shots (7568) are used.

prediction, which measures the fluctuation of the deviation, also decreases, which means the prediction becomes more stable.

Combining electron spectra from several eToFs increases the signal intensities and suppresses the noise. However, the eToF signals cannot be added on top of each other directly, due to the different calibrations of each eTOF. As mentioned before, we put the signals from different eToFs together to form a larger vector and differences of eToFs are automatically taken into account when calculating the response matrix. The upper panel and the lower panel of Fig. 6 show the spectrum of a random shot where one eToF with strongest signal and six eToFs are used, respectively. Compared with the Gaussian convolved spectrometer measurement clearly indicates the advantages of using six eToFs. The inset plot shows that the normalized deviation drops gradually from 1 for one eToF to 0.87 with six eToFs. The data from different eToFs complement with each other and improve the correlation with the spectrometer measurement thus resulting in the better overall reconstructed spectrum.

Our analysis indicates that the performance of the ghost imaging reconstruction depends on experimentally controllable parameters, number of shots used, number of eTOFs used. Ghost imaging is based on the correlation between the object measurement and the reference measurement, i.e. the sensitivity of the cookie-box signals to the fluctuations of the incident



FIG. 6. Improved reconstruction as a function number of eTOFs used. The reconstructed spectrum and Gaussian convolved spectrum using one eToF (a) and six eToFs (b). All the shots are used to get a converged result. The inserted plot shows the decrease in the standard deviation when more eToFs are used.

spectrum as measured by a grating spectrometer. Obtaining better correlation function and reconstruction, i.e. response matrix and spectrum with higher resolution, requires more data points within the Ne 1s photoelectron peak as well as high signal-to-noise ratio. More data points in the eTOF spectrum can be obtained by increasing the retardation voltages to slow the electrons, using larger drift length tubes, or, more simply by increasing the digitizer sampling rate which is presently 2 GHz. In addition, increased detection sensitivity can be readily achieved by using more eToFs or by increasing the gas density to produce more photoelectrons and a higher signal-to-noise ratio (see discussion in Supplementary Note 3).

III. DISCUSSION

Despite the considerable improvement to achieve resolution $\Delta E/E \sim 1/2000$, the ghostimaging reconstruction of a single-shot XFEL spectrum under the current experimental conditions can not characterize completely the SASE structure containing inter-spike spacings down to ~ 0.1 eV, corresponding to a required resolution of $\Delta E/E \sim 1/10000$. For this particular case using the Ne 1s photoelectron, the width of the final state Ne 1s⁻¹ of 0.27 eV represents another barrier. However, the ability to reconstruct an averaged spectral



FIG. 7. Effect of averaging on the deviation between ghost-imaging-reconstructed and gratingbased spectra. (a) Upper panel shows the averaged spectrum for a group of 1000 shots. The spectrum is divided into regions 1-4, going from low to high photon energies. Lower panel shows corresponding spectral percentage deviation for a single 1000-shot group (dashed) and averaged over 7 1000-shot groups (solid). (b) The percentage deviation as a function of number of averaged shots for spectral regions 1-4.

profile with high fidelity is of considerable interest. High-precision incident spectra obtained by averaging are extremely useful for transient absorption measurements, e.g. when a dispersive spectrometer is placed after the sample to extract spectral features below the SASE bandwidth as was done previously in the XUV spectral range for strong-field induced modifications of the lineshape of a doubly-excited state in He [37]. This averaging method is very common for pump/probe transient absorption experiments, e.g. with broadband soft x-ray high-harmonic generation (HHG) sources where single-shot spectra sequentially taken with pump-on and pump-off configurations are averaged to obtain spectral transients [38, 39].

The effect of shot averaging for ghost-imaging reconstruction is shown in Fig. 7 where the deviation between the ghost-imaging-reconstructed spectrum and the grating spectrum is shown. These deviations were evaluated as follows: measurements were randomly selected to form 7 groups of spectra with X shots in each group. The spectra within each group were then ensemble averaged. Fig. 7**a** shows the result for X=1000 shots with the lower panel displaying the normalized deviations ($\Delta s/s$) for photon energies, *i*:

$$|\Delta s/s|_{i} = \frac{\sum_{k=1}^{X} \left| c_{i}^{k} - s_{i}^{k} \right| / s_{i}^{k}}{X} \tag{4}$$

where the upper index k denotes the shot number. The deviation for one group is shown as a gray-dashed line, and that for the average of 7 groups is shown as a black-solid line.

The deviations show a spectral dependence as is clear from the lower panel of Fig. 7a. The data were divided into 4 regions separated at 901.75, 907.5, 913.25 eV as depicted in Fig. 7a. The percentage deviations $(\Delta s/s)$ for each region are shown in Fig. 7b as a function of the number of shots averaged. The $\Delta s/s$ decreases from around 28% for single-shot to 3% and 1% for 100 and 1000 shots, respectively. It is clear that the ghost imaging reconstructed spectrum matches significantly better with the grating spectrum after averaging hundreds of shots. This demonstrates the accuracy of the calculated response matrix. If the singleshot deviation comes from random noise, the deviation after averaging X shots will be proportional to $1/\sqrt{X}$. The log-log plot inset in Fig. 7b clearly shows a negative power relationship. A curve fit of the data in region (2) yields a function of $1/X^{0.45}$, which is close to the expected $1/\sqrt{X}$. We note that the deviation is somewhat larger in region (1) which corresponds to the low-photon-energy, low-photoelectron-kinetic-energy region. This may due to the small cookie-box signals (corresponding to a low signal-to-noise ratio) for electrons with lower kinetic energy. Region (1) also has a relatively small 0.53 Pearson coefficient (see further discussion in Supplementary Note 2). Averaging to achieve a $\sim 1\%$ precision after ~ 1000 shots (requiring only 1 ms at MHz repetition rates using the noninvasive photoelectron spectroscopy scheme) can foster the realization of transient absorption measurements at FELs [37].

Returning to the single-shot spectral profile measurements, the ghost imaging reconstruction demonstrated here is easy to apply for better calibration and resolution improvement of other instruments designed for XFEL diagnostics such as the newly inaugurated angleresolved photoelectron spectroscopy (ARPES) instrument at LCLS [30]. After a training period using multiple eTOFs in conjunction with a high-resolution spectrograph to obtain a converged response matrix, spectral profiles of new shots with enhanced resolution can be obtained at MHz repetition rates. From an XFEL-machine perspective, the enhanced energy resolution for an ARPES-based x-ray photon diagnostic, which has already demonstrated characterization of spatial, temporal and polarization properties, is a sought-after breakthrough since it enables a deeper understanding of the machine operation and allows for a fast-feedback on SASE-formation characteristics.

From a scientific perspective, the high-resolution, non-invasive single-shot incident xray spectrum characterization achieved here is anticipated to benefit standard photonin/photon-out transient absorption spectroscopy at XFELs enabling exploration of nonlinear effects arising from propagation through dense absorbing media [40]. It represents a step forward for all techniques that require incident spectral characterization such as s-TrueCARS [19] and others that take advantage of the intrinsic stochastic nature of XFEL pulses [17, 18, 20]. Moreover, an incident pulse spectral characterization should enable a greater depth of understanding for processes where the SASE-pulse structure can play an important role, such as the recently-discovered transient resonance phenomena in core-hole dynamics in gaseous media which rely on mapping out narrow energy levels of highly elusive states of matter [7], SASE-FEL studies of chiral dynamics using photoelectron circular dichroism which have been compromised by averaging over subtle dynamics due to the large bandwidth [41] and resonance-enhanced scattering for single-particle imaging [42]. In summary, the use of a multiple photoelectron spectrometer array as a transparent highresolution beamsplitter as demonstrated in this work is expected to be a huge asset for both the technological and scientific development of x-ray spectroscopies at XFELs.

IV. METHODS

A. XFEL photon delivery

Our experiment was performed on the SQS (Small Quantum Systems) branch of the SASE3 beamline at the European XFEL [43, 44] with SASE soft x-rays at 910 eV central photon energy. The averaged FWHM bandwidth of the XFEL pulses was 9 eV and the standard deviation of pulse energy fluctuation was 9% for an average pulse energy of 3.8 mJ as measured with an x-ray gas monitor detector (XGM). The XFEL ran at a 10 Hz repetition rate over a 25 minutes data acquisition time to obtain N = 15337 shots.

B. Electron measurement - cookie-box photoelectron spectrometer array

The cookie-box is located far from any x-ray focus points and the SASE beam spot size was estimated to be ~ 5 mm in diameter, ensuring the photoionization remains within the linear regime. The number of photoelectrons generated is proportional to the product of the gas density and the photoionization cross section. The base background gas pressure in the chamber is 1×10^{-8} mbar and the pressure of gas injected was adjustable from 1×10^{-7} mbar to 1×10^{-5} mbar. The gas density was set to 2.5×10^{-7} during our experiment. The retardation voltage of 30 V slowed photoelectrons with 40 eV initial kinetic energy to 10 eV. The total time-of-flight for Ne 1s photoelectrons from the interaction region to the detector is ~ 60 ns (see ToF signals in Supplementary Note 1). The detector signals from the microchannel plate (MCP) stack were recorded every 0.5 ns. The electrons were slowed in order to create a 1s photoelectron peak with more ToF sampling points while keeping the signal well above the background.

C. Photon measurement - grating spectrograph

The FEL beam (3.8 mJ/pulse) was attenuated prior to the spherical mirror with Kr gas (transmission = 35.5%); combined with the grating efficiency of 36%, 0.49 mJ was incident on the screen. The VLS grating has a groove density of 150 lines/mm, with the imaging screen located at 99 mm distance from the grating, in the focus of the spherical premirror. The emitted fluorescence from the Ce:YAG screen was detected by a camera to produce the photon spectrum [31]. The spectral range recorded on the YAG screen was from 895.5 eV to 919.8 eV and was spread over 1900 pixels. The estimated resolving power for the spectrometer, based on independent measurements, is $E/\Delta E = 10000$ [45]. This allows to resolve the single SASE spikes of the XFEL pulses, which show a minimum spacing of $\sigma = 90$ meV in the present measurements.

V. DATA AVAILABILITY

The experimental data were collected during beamtime 2935 at the European XFEL. The metadata are available at [https://in.xfel.eu/metadata/doi/10.22003/XFEL.EU-DATA-002935-00].

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AUTHOR CONTRIBUTIONS

K.L. and L.Y. conceived the use of ghost-imaging reconstruction for high-resolution spectral characterization with multiple photoelectron spectrometers. T.M., J.L., M.M., K.L., L.Y. planned and designed the experiment. T.M. and J.L. set up the experimental configuration and performed data collection together with K.L., D.K., G.D., A.P., M.M., M.I. and L.Y.. S.S. and N.R. provided discussions on spectral averaging analysis. K.L. performed data analysis and together with L.Y. interpretation. K.L. and L.Y. wrote the paper. All authors discussed the results and contributed to the final manuscript.

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Supplementary information of "Ghost-imaging-enhanced non-invasive spectral characterization of stochastic x-ray free-electron-laser pulses"

Kai Li,^{1,2,*} Joakim Laksman,³ Tommaso Mazza,³ Gilles Doumy,²

Dimitris Koulentianos,² Alessandra Picchiotti,⁴ Svitovar Serkez,³ Nina

Rohringer,^{5,6} Markus Ilchen,⁷ Michael Meyer,³ and Linda Young^{1,2,8,†}

¹Department of Physics, The University of Chicago, Chicago, IL 60637 USA ²Chemical Sciences and Engineering Division,

Argonne National Laboratory, Lemont, IL 60439 USA

³European XFEL, Holzkoppel 4, 22869 Schenefeld Germany

⁴The Hamburg Centre for Ultrafast Imaging, Hamburg University, Luruper Chaussee 149, 22761, Hamburg, Germany

> ⁵Center for Free-Electron Laser Science CFEL, Deutsches Elektronen-Synchrotron DESY,

Notkestraße 85, 22607 Hamburg, Germany ⁶Department of Physics, Universität Hamburg, 20355 Hamburg, Germany

⁷Deutsches Elektronen-Synchrotron DESY, Notkestraße 85, 22607 Hamburg, Germany

⁸James Franck Institute, The University of Chicago, Chicago, IL 60637 USA (Dated: April 11, 2024)

^{*} kail@anl.gov

[†] young@anl.gov

I. SUPPLEMENTARY NOTE 1: DETAILS OF ETOF PERFORMANCE

The single-shot and shot-averaged signals (y) from one eToF along the polarization direction are shown in Supplementary Fig. 1. The standard deviation of the signals $\sigma_y(\omega)$ at different photon energies are shown in shaded region. The photoionization of different atomic sub-shell electrons and Auger decay lead to different peaks as denoted in the figure. With 2.4×10^{-7} mbar and 0.3 Mb Ne 1s photoionization cross section at 910 eV [1], an incident x-ray pulse with an average of 2.6×10^{13} photons would generate around 144000 photoelectrons per pulse. Given the geometry of the cookie-box spectrometer [2], ~ 300 Ne 1s photoelectrons are detected by each eToF along the polarization direction. The x-ray beam diameter in the cookie-box is estimated to be 5 mm. For a 40 eV Ne 1s photoelectron, this beam diameter creates a flight path ToF delay of $\Delta t = 1.3$ ns, which limits the raw cookie-box resolution to above 0.9 eV. The $\sigma_y(\omega)$ represents the shot-to-shot fluctuation of SASE pulses plus the noise of the ToF. As shown below in Supplementary Fig. 3a, the standard deviation to mean value ratio $(\sigma_y(\omega)/\bar{y}(\omega))$ is calculated to represent the noiseto-signal ratio of the eToF signals. The background of the eToF signals is assumed to be equal to the average signal between 100 to 120 ns. It is subtracted on a shot-by-shot basis to obtain background-free signals.



Supplementary Figure 1. Cookie-box photoelectron signal of one eToF along the polarization direction. The averaged and single-shot signal is in red solid and blue dashed line, respectively. The standard deviation of signals is in pink shaded area.

II. SUPPLEMENTARY NOTE 2: CORRELATION ANALYSIS

The analysis of correlations between the true photon spectrum and ghost-imagingreconstructed spectrum are shown in Supplementary Fig. 2. The spectral intensity is integrated over 1-eV energy bins. For the bin between 908 to 909 eV, the correlation of 5000 shots is shown in (**a**). A good correlation is indicated by the dots along the line (gray dashed) with a slope equaling one. The Pearson correlation coefficient [3] across the spectrum is shown in (**b**). The Pearson coefficient stays around 0.75 at the central photon energy and decreases to 0.5 at the two wings.



Supplementary Figure 2. The correlation between the true photon spectrum from the spectrometer and the ghost-imaging-reconstructed spectrum. **a** The correlation between photon spectrum and ghost imaging reconstructed spectrum integrated within 908 - 909 eV. **b** Pearson correlation coefficient at different photon energies.

III. SUPPLEMENTARY NOTE 3: LIMITATIONS TO SINGLE-SHOT RECON-STRUCTION

The ghost imaging reconstruction works by learning the response of cookie-box and then using the response matrix to predict the incident spectrum based on the cookie-box signal. The predictive power is limited by the information recorded in the cookie-box measurement, i.e. the cookie-box signal-to-noise ratio and the number of ToF points within the Ne 1s photoelectron peak.



Supplementary Figure 3. Improved signal to noise with increased Ne pressure. (a) Standard deviation to mean value ratio of cookie-box and spectrometer signal with different gas pressure. The ghost imaging reconstructed spectrum and convolved photon spectrum at (b) 1.8×10^{-7} mbar, (c) 3.2×10^{-7} mbar.

To estimate the noise level of signals, we calculated the standard deviation to mean value ratio at different photon energies $\sigma_y(\omega)/\bar{y}(\omega)$ for the cookie-box and spectrometer measurements. Supplementary Fig. 3a shows the mean value of $\sigma_y(\omega)/\bar{y}(\omega)$ within the main peak 900.5 $\leq \omega \leq$ 911 eV with different gas densities inside the cookie-box. The averaged standard deviation to mean value ratio (SMR) of spectrometer stays the same while the SMR value of cookie-box decreases with higher gas pressure. As mentioned before, the standard deviation of cookie-box signals comes from both the fluctuation of SASE pulse and the noise in the eToF signal. Assuming the noise of spectrometer can be ignored, the deviation of SMR value from the value of spectrometer measures the noise level of cookiebox. As expected, with higher gas density, the SMR of cookie-box decreases and approaches that of the spectrometer, which indicates lower noise level, i.e. better signal-to-noise ratio, when more photoelectrons are generated. The ghost imaging reconstructed spectrum and convolved photon spectrum of a random shot at different gas pressure 1.8×10^{-7} and 3.2×10^{-7} mbar are shown in Supplementary Fig. 3b and c, respectively.



Supplementary Figure 4. The ghost imaging reconstructed single-shot spectrum and convolved photon spectrum with ToF peak at ~ 50 ns (**a**) and ~ 60 ns (**b**)

The ghost imaging reconstructed spectrum and convolved photon spectrum with ToF peaks at ~ 50 and ~ 60 ns are shown in Supplementary Fig. 4a and b respectively. The inserted figures show the ToF signals. There are around 40 ToF points within the major part of Ne 1s peak located ~ 50 ns and 20 more points within the major peak at ~ 60 ns. Clearly the measurement with more ToF points contains more SASE information, thus gives a better reconstructed spectrum. Note that there is a trade-off between keeping a good signal-to-noise ratio and slowing down electrons to obtain more ToF points. The signals becomes smaller with the electrons spread out over a larger ToF range. The pressure used in the

experiment was below the maximum allowed in the chamber 1×10^{-5} mbar [4].

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